

P-Channel Enhancement-Mode MOS Transistor**Product Summary**

| V_{(BR)DSS} Min (V) | r_{DS(on)} Max (Ω) | V_{GS(th)} (V) | I_D (A) |
|------------------------------------|-----------------------------------|-------------------------------|--------------------------|
| -20 | 1.4 @ V _{GS} = -10 V | -1.3 to - 3 V | -0.31 |
| | 3.5 @ V _{GS} = -4.5 V | -1.3 to - 3 V | -0.16 |

For applications information see AN804.

Features

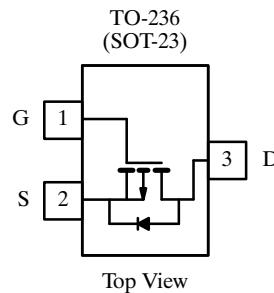
- High-Side Switching
- Low On-Resistance: 0.9 Ω
- Low Threshold: -2.1 V
- Fast Switching Speed: 18 ns
- Low Input Capacitance: 55 pF

Benefits

- Ease in Driving Switches
- Low Offset (Error) Voltage
- Low-Voltage Operation
- High-Speed Switching
- Easily Driven Without Buffer

Applications

- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc.
- Battery Operated Systems
- Power Supply, Converter Circuits
- Motor Control



TP0202T (P3)*

*Marking Code for TO-236

Absolute Maximum Ratings (T_A = 25°C Unless Otherwise Noted)

| Parameter | Symbol | Limit | Unit |
|---|-----------------------------------|------------|------|
| Drain-Source Voltage | V _{DS} | -20 | V |
| Gate-Source Voltage | V _{GS} | ±20 | |
| Continuous Drain Current (T _J = 150°C) | I _D | -0.31 | A |
| | | -0.25 | |
| Pulsed Drain Current | I _{DM} | -0.75 | |
| Power Dissipation | P _D | 0.2 | W |
| | | 0.128 | |
| Maximum Junction-to-Ambient | R _{thJA} | 625 | °C/W |
| Operating Junction and Storage Temperature Range | T _J , T _{stg} | -55 to 150 | °C |

Notes

a. Pulse width limited by maximum junction temperature.

TP0202T

TEMIC

Siliconix

Specifications^a

| Parameter | Symbol | Test Conditions | Limits | | | Unit |
|---|----------------------|---|--------|------------------|-----------|------|
| | | | Min | Typ ^b | Max | |
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} = 0 V, I _D = -10 µA | -20 | -25 | | V |
| Gate-Threshold Voltage | V _{GS(th)} | V _{DS} = V _{GS} , I _D = -0.25 mA | -1.3 | -2.1 | -3 | |
| Gate-Body Leakage | I _{GSS} | V _{DS} = 0 V, V _{GS} = ±20 V | | | ±100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = -16 V, V _{GS} = 0 V T _J = 55°C | | | -1 -10 | µA |
| On-State Drain Current ^c | I _{D(on)} | V _{DS} = -10 V, V _{GS} = -10 V | -0.5 | -0.75 | | A |
| Drain-Source On-Resistance ^c | r _{DS(on)} | V _{GS} = -4.5 V, I _D = -0.05 A | | 1.7 | 3.5 | Ω |
| | | V _{GS} = -10 V, I _D = -0.2 A | | 0.9 | 1.4 | |
| Forward Transconductance ^c | g _f | V _{DS} = -10 V, I _D = -0.2 A | 250 | 600 | | mS |
| Diode Forward Voltage | V _{SD} | I _S = -0.25 A, V _{GS} = 0 V | | -0.9 | -1.5 | V |
| Dynamic | | | | | | |
| Total Gate Charge | Q _g | V _{DS} = -16 V, V _{GS} = -10 V, I _D ≈ -200 mA | | 2700 | | pC |
| Gate-Source Charge | Q _{gs} | | | 500 | | |
| Gate-Drain Charge | Q _{gd} | | | 600 | | |
| Input Capacitance | C _{iss} | V _{DS} = -15 V, V _{GS} = 0 V, f = 1 MHz | | 55 | | pF |
| Output Capacitance | C _{oss} | | | 50 | | |
| Reverse Transfer Capacitance | C _{tss} | | | 18 | | |
| Switching^d | | | | | | |
| Turn-On Time | t _{d(on)} | V _{DD} = -15 V, R _L = 75 Ω I _D ≈ -0.2 A, V _{GEN} = -10 V R _G = 6 Ω | | 8 | 12 | ns |
| | t _r | | | 20 | 30 | |
| Turn-Off Time | t _{d(off)} | | | 20 | 35 | |
| | t _f | | | 30 | 40 | |

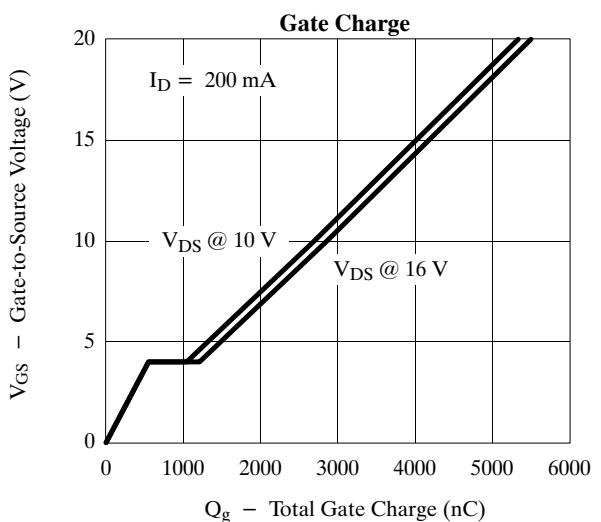
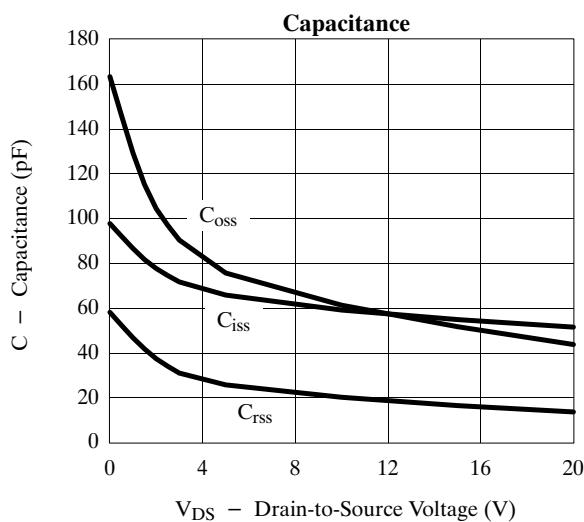
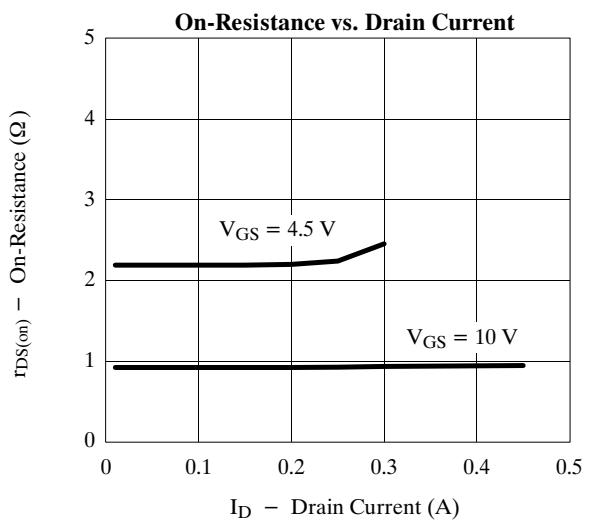
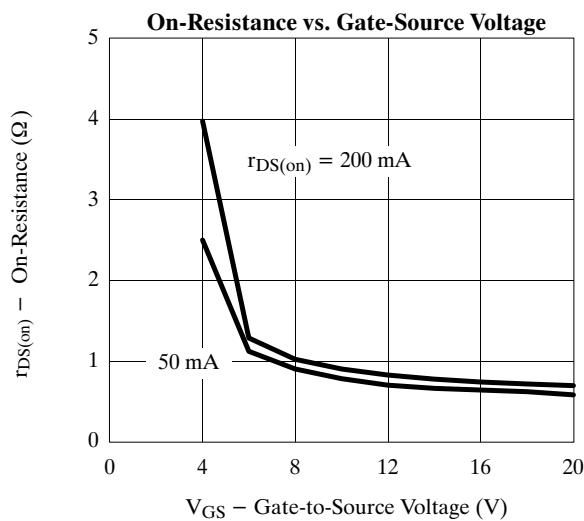
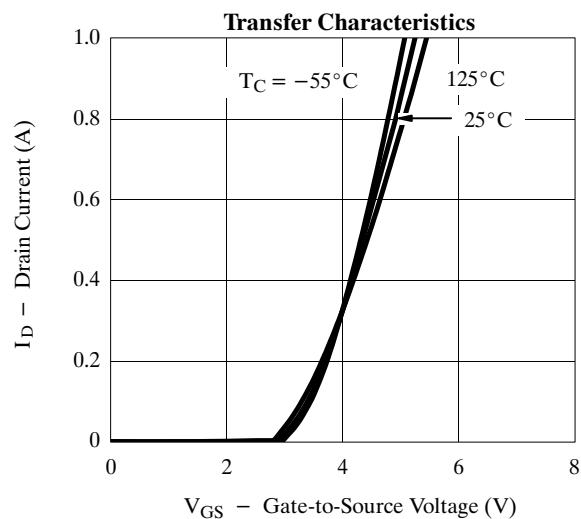
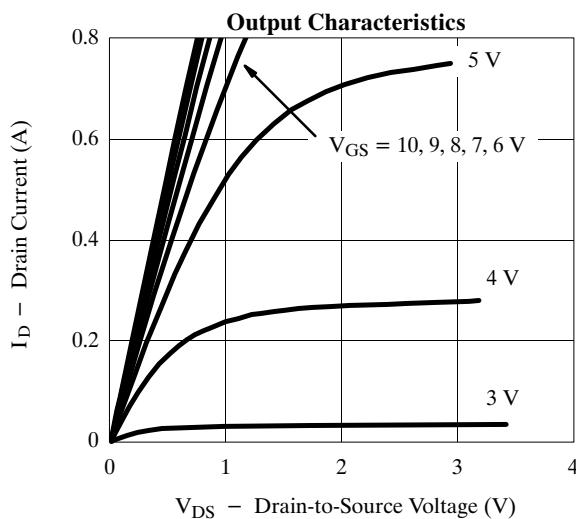
Notes

- a. T_A = 25°C unless otherwise noted.
- b. For DESIGN AID ONLY, not subject to production testing.
- c. Pulse test: PW ≤ 300 µs duty cycle ≤ 2%.
- d. Switching time is essentially independent of operating temperature.

VPBP02

Typical Characteristics (25°C Unless Otherwise Noted)

Negative signs omitted for clarity.



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Negative signs omitted for clarity.

